

Notice of References Cited

Application/Control No.

09/670,152

Applicant(s)/Patent Under
Reexamination
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Examiner

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Art Unit

3661

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,049,753	04-2000	Nimura, Mitsuhiro	701/201
	B	US-2001/0001848	05-2001	OSHIZAWA et al.	701/210
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

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